Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/626,668	PEACE, TERRENCE B.
	Examiner	Art Unit
	Peter Coughlan	2129

SEARCHED			
Class	Subclass	Date	Examiner
706	20	10/24/2006	PDC
706	18	10/24/2006	PDC
706	17	10/24/2006	PDC
706	45	10/24/2006	PDC
707	6	10/24/2006	PDC

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East--statistic, test, formula, algorithm, classify, Monte Carlo, random, linear, error, prediction, proximity	10/24/2006	PDC
East--II--groups, sets, clusters, compare, distribution, dimension, size, design w/ experiments, probability, specify,	10/24/2006	PDC
IEEE, vector, threshold, proximity, error, random, monte carlo, statistic, probability, design w/ experiments, dimension,	10/24/2006	PDC
IEEE--II--percentage, threshold, data set, vector, input, code, keyboard, communication, computer,	10/24/2006	PDC
InventorTerrence B Peace	10/24/2006	PDC
707.6 with data w/dimensions, data w/probability distribution, data w/size 'M'	10/24/2006	PDC

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner